

DK-81854-UL

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

CB TEST CERTIFICATE

P	roc	luc	t

Name and address of the applicant

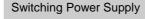
Name and address of the manufacturer

Name and address of the factory

Note: When more than one factory, please report on page 2

Ratings and principal characteristics

Trademark (if any)



ARCH ELECTRONICS CORP 3F, NO. 79, SEC1, HSIN TAI WU RD., HSI CHIH, NEW TAIPEI CITY, 221,TAIWAN

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I/P: 100-240Vac, 47-63Hz, 9.6A max. O/P: See test report for details



Type of Customer's Testing Facility (CTF) Stage used

Model / Type Ref.

Additional information (if necessary may also be reported on page 2)

A sample of the product was tested and found to be in conformity with

As shown in the Test Report Ref. No. which forms part of this Certificate

AQF700-XS, AQF700C-XS, MQF700-XS, and MQF700C-XS (X can be 9-12.6, 11.25-15.75, 18- 25.2, 21-29.4 and 36-50.4)

Additionally evaluated to EN 62368-1:2014 / A11:2017 National Difference specified in the CB Test Report

IEC 62368-1:2014

1807029-CB issued on 2019-03-06

This CB Test Certificate is issued by the National Certification Body



UL (US), 333 Pfingsten Rd IL 60062, Northbrook, USA UL (Demko), Borupvang 5A DK-2750 Ballerup, DENMARK UL (JP), Marunouchi Trust Tower Main Building 6F, 1-8-3 Marunouchi, Chiyoda-ku, Tokyo 100-0005, JAPAN UL (CA), 7 Underwriters Road, Toronto, M1R 3B4 Ontario, CANADA For full legal entity names see www.ul.com/ncbnames

Date: 2019-03-25

Signature:

 \times

Jan-Erik Storgaard